

Supporting Information for

Cooperative Roles of Chemical Reactions and Mechanical Friction in Chemical Mechanical Polishing of Gallium Nitride Assisted by OH Radicals: Tight-Binding Quantum Chemical Molecular Dynamics Simulations

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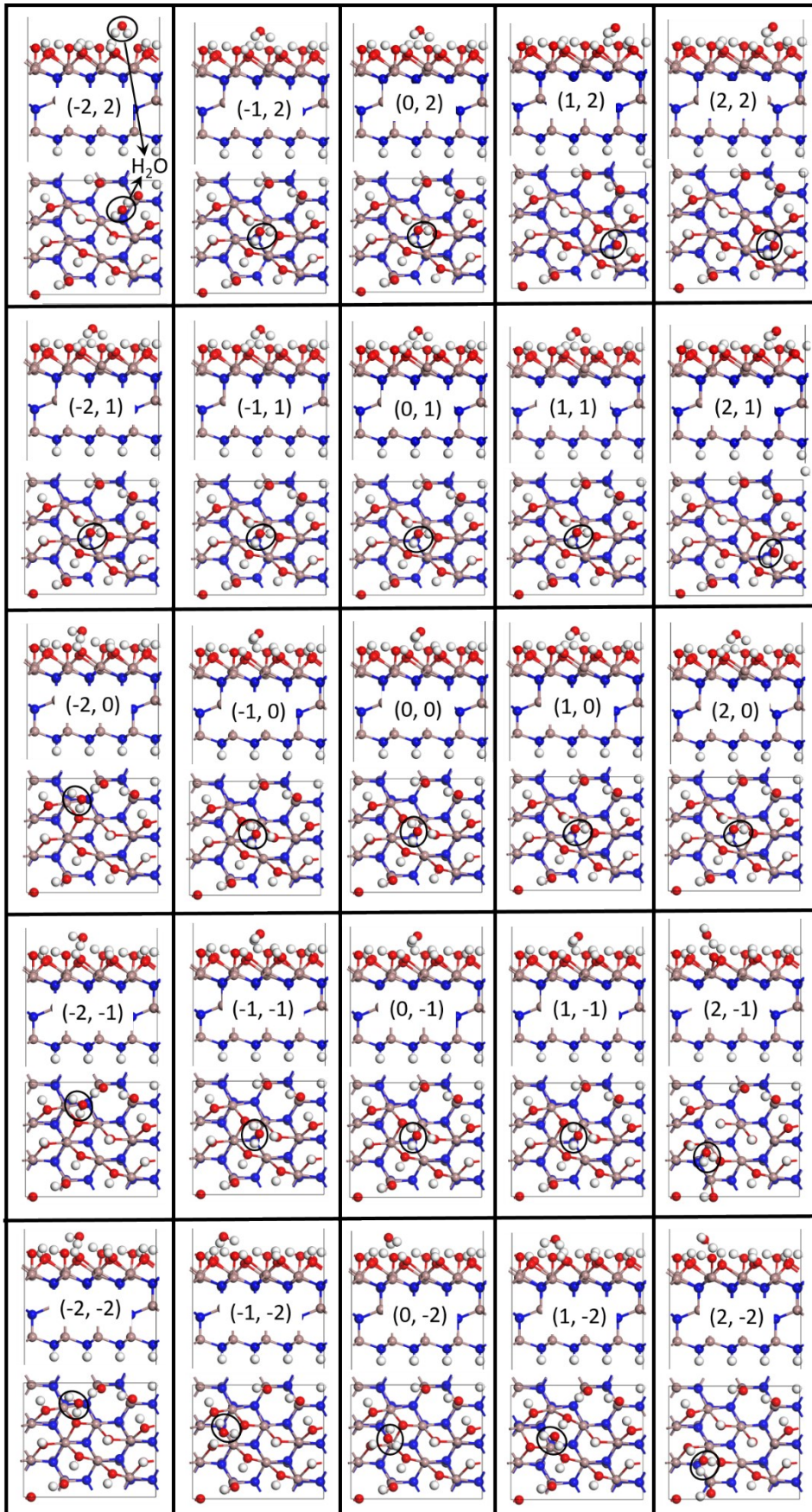


Figure S1. Post-optimized structure of GaN substrate structures of GaN substrate with 25 different initial positions of OH radical. The model of GaN substrate is the same as that in Figure 8 of manuscript, while the x - and y -positions of the OH radical are varied. In details, the positions of OH radical in Figure 8 is set as a datum point, and (i, j) indicates that the OH radical is moved with i Å along x -direction and j Å along y -direction from the datum point. For all calculations, front view and top view are given.